Appl. no. 10/815,400 IDS dated June 1, 2009

Modified Form PTO/SB/08A

Substitute for form 1449A/PTO	Complete If Known			
	Application Number	10/815,400		
INFORMATION DISCLOSURE	First Named Inventor	Eldridge et al.		
STATEMENT BY APPLICANT	Filing Date	March 31, 2004		
(use as many sheets as necessary)	Group Art Unit	2829		
	Examiner Name	Ernest F. Karlsen		
No. of Refs.: 3	Attorney Docket No.	P71C2-US		

U.S. PUBLISHED PATENT DOCUMENTS							
Examiner	Cite	U.S. Patent Doc	ument	Name of Patentee or	Publ./Issue	Related*	Copy
Initials*	No.1	Number K	ind Code ²	Applicant	Date		Enclosed
	1.	3806801		Bove	4/23/1974		No***

	OTHER PRIOR ART – NONPATENT LITERATURE DOCUMENTS				
Examiner	Cite	Include name of the author (in CAPITAL LETTERS), title of the article (when	T ²	Copy	
Initials"	No.1			Enclosed	
		date, page(s), volume-issue number(s), publisher, city and/or country where published			
	2.	Taber et al. "Vertical Probing Experiences," International SEMATECH		Yes	
		Wafer Probe Council, 2003 Southwest Test Workshop (2003) 29 pages			
	3.	Mann, "'Leading Edge' Of Wafer Level Testing," 2004 Southwest Test		Yes	
		Workshop (2004) 64 pages			

Examiner	Date	
Signature	Considered	

^{*} EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

*Unique citation designation number. *See attached Kinds of U.S. Patent Documents. *Enter Office that issued the document, by the two-letter code (WPIO Standard ST.3.) *Fee Japanese patent documents, the indication of the year of the reign of the Emporer must preced the serial number of the patent document. *Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. *Applicant is to place a check mark here if English Imaguage Translation is statched.

^{**} Reference cited in parent application US Serial No. ______. CFR § 1.98(d)

^{***} Pre-OG Notice By Deputy Commissioner Stephen G. Kunin dated July 11, 2003 waiving the requirement to file copies of US patent publications in applications filed after June 30, 2003.

[&]amp; Notice dated October 19, 2004 by Deputy Commissioner for Patent Examination Policy waiving requirement to file copies of pending US patent applications if the applications are stored in the USPTO's IFW system.

[#] Commonly owned US patent or application whose subject matter may be related to the subject matter of the instance patent application.